Document Number: MC33660 Rev 6.0, 7/2016

### ISO K line serial link interface

The 33660 is a serial link bus interface device designed to provide bi-directional half-duplex communication interfacing in automotive diagnostic applications. It is designed to interface between the vehicle's on-board microcontroller, and systems off-board the vehicle via the special ISO K line. The 33660 is designed to meet the Diagnostic Systems ISO9141 specification. The device's K line bus driver's output is fully protected against bus shorts and over-temperature conditions.

The 33660 derives its robustness to temperature and voltage extremes by being built on a SMARTMOS process, incorporating CMOS logic, bipolar/MOS analog circuitry, and DMOS power FETs. Although the 33660 was principally designed for automotive applications, it is suited for other serial communication applications. It is parametrically specified over an ambient temperature range of -40 °C  $\leq$  T $_A$   $\leq$  125 °C and 8.0 V  $\leq$  V $_{BB}$   $\leq$  18 V supply. The economical SO-8 surface-mount plastic package makes the 33660 very cost effective.

#### Features

- Operates over a wide supply voltage of 8.0 V to 18 V
- Operating temperature of -40 °C to 125 °C
- · Interfaces directly to standard CMOS microprocessors
- · ISO K line pin protected against shorts to battery
- · Thermal shutdown with hysteresis
- · ISO K line pin capable of high currents
- ISO K line can be driven with up to 10 nF of parasitic capacitance
- · 8.0 kV ESD protection attainable with few additional components
- Standby mode: no  $V_{BAT}$  current drain with  $V_{DD}$  at 5.0 V
- Low current drain during operation with V<sub>DD</sub> at 5.0 V

### 33660

#### **ISO9141 PHYSICAL INTERFACE**



EF SUFFIX (PB-FREE) 98ASB42564B 8-PIN SOICN

#### **Applications**

- · Farm equipment
- · Automotive systems
- Industrial equipment
- Robotic equipment
- Applications where module-to-module communications are required
- · Marine and aircraft networks

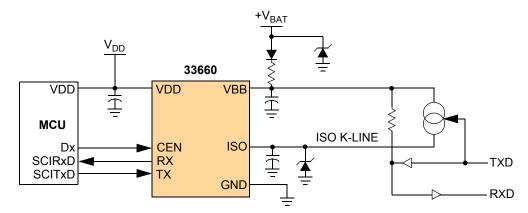


Figure 1. 33660 simplified application diagram



# 1 Orderable parts

Table 1. Orderable part variations

Part number (1)	Temperature (T <sub>A</sub> )	Package	Parameter	Symbol	Condition	33660	33660B <sup>(2)</sup>
	VBB Load Dump Peak Voltage (in  VBB(5a)  Pulse 5a 470 ohm series resistor and 100 nF capacitor to GND on VBB		_	82 V			
MC33660EF	-40 °C to 125 °C	8-SOICN	accordance with ISO 7637-2 & ISO 7637-3)	V <sub>BB(5b)</sub>	Pulse 5b 470 ohm series resistor and 100 nF capacitor to GND on VBB	45 V	45 V
MC33660BEF			Module Level ESD (Air Discharge, Powered)	V <sub>ESD4</sub>	33 V zener diode and 470 pF capacitor to GND on ISO	-	±25000 V

#### Notes

- 1. To order parts in tape & reel, add the R2 suffix to the part number.
- 2. Recommended for all new designs

# 2 Internal block diagram

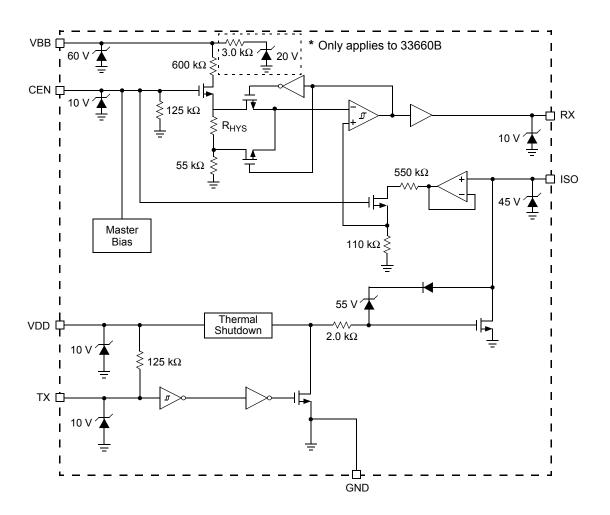


Figure 2. 33660 simplified internal block diagram

# 3 Pin connections

## 3.1 Pinout diagram

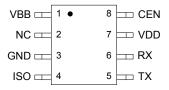


Figure 3. 33660 pin connections

### 3.2 Pin definitions

Table 2. 33660 pin definitions

Pin Number	Pin Name	Definition
1	VBB	Battery power through external resistor and diode.
2	NC	Not to be connected. (3)
3	GND	Common signal and power return.
4	ISO	Bus connection.
5	TX	Logic level input for data to be transmitted on the bus.
6	RX	Logic output of data received on the bus.
7	VDD	Logic power source input.
8	CEN	Chip enable. Logic "1" for active state. Logic "0" for sleep state.

#### Notes

3. NC pins should not have any connections made to them. NC pins are not guaranteed to be open circuits.

## 4 Electrical characteristics

### 4.1 Maximum ratings

#### Table 3. Maximum ratings

All voltages are with respect to ground unless otherwise noted. Exceeding these ratings may cause a malfunction or permanent damage to the device.

Symbol	Rating	Value	Unit	Notes
V <sub>DD</sub>	VDD DC Supply Voltage	-0.3 to 7.0	V	
$V_{BB(5a)} \ V_{BB(5b)}$	VBB Load Dump Peak Voltage (in accordance with ISO 7637-2 & ISO 7637-3)  • Pulse 5a - 33660B only • Pulse 5b	82 45	V	
$V_{ISO}$	ISO Pin Load Dump Peak Voltage	40	V	(4)
V <sub>ESD1</sub> V <sub>ESD2</sub>	ESD Voltage  • Human Body Model  • Machine Model  33660	±2000 ±150 ±200		(5) (6) (6)
V <sub>ESD3-1</sub> V <sub>ESD3-2</sub>	33660B  • Charge Device Model  Corner Pins  All other Pins	±750 ±500	V	(6)
V <sub>ESD4</sub>	Module Level ESD (Air Discharge, Powered)     33660B only     ISO pin with 33 V zener diode and 470 pF capacitor to GND -	±25000		(7)
E <sub>CLAMP</sub>	ISO Clamp Energy	10	mJ	(8)
T <sub>STG</sub>	Storage Temperature	-55 to +150	°C	
T <sub>C</sub>	Operating Case Temperature	-40 to +125	°C	
T <sub>J</sub>	Operating Junction Temperature	-40 to +150	°C	
$P_{D}$	Power Dissipation T <sub>A</sub> = 25 °C	100	mW	
T <sub>PPRT</sub>	Peak Package Reflow Temperature During Reflow	Note 10.	°C	(9), (10)
$R_{\theta JA}$	Thermal Resistance: Junction-to-Ambient	150	°C/W	

#### Notes

- 4. Device will survive double battery jump start conditions in typical applications for 10 minutes duration, but is not guaranteed to remain within specified parametric limits during this duration.
- 5. ESD data available upon request.
- 6. ESD1 testing is performed in accordance with the Human Body Model ( $C_{ZAP}$  = 100 pF,  $R_{ZAP}$  = 1500  $\Omega$ ), ESD2 testing is performed in accordance with the Machine Model ( $C_{ZAP}$  = 200 pF,  $R_{ZAP}$  = 0  $\Omega$ ), ESD3 testing is performed in accordance with the Charge Device Model ( $C_{ZAP}$  = 4.0 pF).
- 7. ESD4 testing is performed in accordance with ISO 10605 ESD model (C = 330 pF, R = 2.0 kΩ). ESD discharges start at ±5.0 kV and go up to ±25 kV in increments of 5.0 kV. There are two positions for discharges: 8.0 cm cable from ISO connector, 85 cm cable from ISO connector. There are 10 ESD discharges per voltage at each cable position at a minimum of 1.0 s intervals. Remaining charge is not bled off after every discharge.
- 8. Nonrepetitive clamping capability at 25 °C.
- 9. Pin soldering temperature limit is for 10 seconds maximum duration. Not designed for immersion soldering. Exceeding these limits may cause malfunction or permanent damage to the device.
- 10. Freescale's Package Reflow capability meets Pb-free requirements for JEDEC standard J-STD-020C. For Peak Package Reflow Temperature and Moisture Sensitivity Levels (MSL), Go to www.freescale.com, search by part number [e.g. remove prefixes/suffixes and enter the core ID to view all orderable parts. (i.e. MC33xxxD enter 33xxx), and review parametrics.

### 4.2 Static electrical characteristics

Table 4. Static electrical characteristics

Characteristics noted under conditions of 4.75 V  $\leq$  V<sub>DD</sub>  $\leq$  5.25 V, 8.0 V  $\leq$  V<sub>BB</sub>  $\leq$  18 V, -40 °C  $\leq$  T<sub>C</sub>  $\leq$  125 °C, unless otherwise noted.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
wer and contr	rol	<b>,</b>		<b>'</b>		
I <sub>DD(SS)</sub>	$V_{DD}$ Sleep State Current • $T_x = 0.8 V_{DD}$ , CEN = $0.3 V_{DD}$	-	_	0.1	mA	
$I_{DD(Q)}$	V <sub>DD</sub> Quiescent Operating Current • T <sub>X</sub> = 0.2 V <sub>DD</sub> , CEN = 0.7 V <sub>DD</sub>	-	_	1.0	mA	
I <sub>BB(SS)</sub>	$V_{BB}$ Sleep State Current • $V_{BB}$ = 16 V, $T_x$ = 0.8 $V_{DD}$ , CEN = 0.3 $V_{DD}$	-	_	50	μΑ	
I <sub>BB(Q)</sub>	V <sub>BB</sub> Quiescent Operating Current • T <sub>X</sub> = 0.2 V <sub>DD</sub> , CEN = 0.7 V <sub>DD</sub>	-	-	1.0	mA	
V <sub>IH(CEN)</sub> V <sub>IL(CEN)</sub>	Chip Enable Input High Voltage Threshold Input Low Voltage Threshold	0.7 V <sub>DD</sub>	_ _	- 0.3 V <sub>DD</sub>	V	(11) (12)
I <sub>PD(CEN)</sub>	Chip Enable Pull-down Current	2.0	_	40	μΑ	(13)
$V_{IL(TX)}$	T <sub>X</sub> Input Low Voltage Threshold • R <sub>ISO</sub> = 510 Ω	-	-	0.3 x V <sub>DD</sub>	٧	(14)
V <sub>IH(TX)</sub>	$T_X$ Input High Voltage Threshold • $R_{ISO}$ = 510 $\Omega$	0.7 x V <sub>DD</sub>	_	-	٧	(15)
I <sub>PU(TX)</sub>	T <sub>X</sub> Pull-up Current	-40	-	-2.0	μΑ	(16)
V <sub>OL(RX)</sub>	$R_X$ Output Low Voltage Threshold • $R_{ISO}$ = 510 $Ω$ , $T_X$ = 0.2 $V_{DD}$ , $R_X$ Sinking 1.0 mA	-	_	0.2 V <sub>DD</sub>	٧	
V <sub>OH(RX)</sub>	R <sub>X</sub> Output High Voltage Threshold • R <sub>ISO</sub> = 510 Ω, T <sub>X</sub> = 0.8 V <sub>DD</sub> , R <sub>X</sub> Sourcing 250 μA	0.8 V <sub>DD</sub>	_	-	٧	
T <sub>LIM</sub>	Thermal Shutdown	150	170	-	°C	(17)
I/O		-		•		1
V <sub>IL(ISO)</sub>	Input Low Voltage Threshold • R <sub>ISO</sub> = 510 Ω, T <sub>X</sub> = 0.8 V <sub>DD</sub>	_	-	0.4 x V <sub>BB</sub>	V	

V <sub>IL(ISO)</sub>	Input Low Voltage Threshold • R <sub>ISO</sub> = 510 Ω, T <sub>X</sub> = 0.8 V <sub>DD</sub>		-	0.4 x V <sub>BB</sub>	V	
V <sub>IH(ISO)</sub>	Input High Voltage Threshold • R <sub>ISO</sub> = 510 Ω, T <sub>X</sub> = 0.8 V <sub>DD</sub>		-	_	٧	
V <sub>HYS(ISO)</sub>	Input Voltage Hysteresis	0.05 x V <sub>BB</sub>	_	0.1 x V <sub>BB</sub>	V	
I <sub>PU(ISO)</sub>	Internal Pull-up Current • $R_{ISO} = \infty \Omega$ , $T_X = 0.8 V_{DD}$ , $V_{ISO} = 9.0 V$ , $V_{BB} = 18 V$	-5.0	_	-140	μΑ	
I <sub>SC(ISO)</sub>	Short-circuit Current Limit $\bullet$ R <sub>ISO</sub> = 0 $\Omega$ , T <sub>X</sub> = 0.4 V <sub>DD</sub> , V <sub>ISO</sub> = V <sub>BB</sub>	50	_	200	mA	

#### Notes

- 11. When  $I_{BB}$  transitions to >100  $\mu A$ .
- 12. When  $I_{BB}$  transitions to <100  $\mu A$ .
- 13. Enable pin has an internal current pull-down. Pull-down current is measured with CEN pin at  $0.3 \text{ V}_{DD}$ .
- 14. Measured by ramping  $T_X$  down from 0.8  $V_{DD}$  and noting  $T_X$  value at which ISO falls below 0.2  $V_{BB}$ .
- 15. Measured by ramping  $T_X$  up from 0.2  $V_{DD}$  and noting the value at which ISO rises above 0.9  $V_{BB}$ .
- 16.  $T_x$  pin has internal current pull-up. Pull-up current is measured with  $T_X$  pin at 0.7  $V_{DD}$ .
- 17. Thermal Shutdown performance (T<sub>LIM</sub>) is guaranteed by design, but not production tested.

#### Table 4. Static electrical characteristics (continued)

Characteristics noted under conditions of 4.75 V  $\leq$  V<sub>DD</sub>  $\leq$  5.25 V, 8.0 V  $\leq$  V<sub>BB</sub>  $\leq$  18 V, -40 °C  $\leq$  T<sub>C</sub>  $\leq$  125 °C, unless otherwise noted.

Symbol	Characteristic		Тур.	Max.	Unit	Notes
ISO I/O (Continued	l)					
V <sub>OL(ISO)</sub>	Output Low Voltage • $R_{ISO}$ = 510 $\Omega$ , $T_X$ = 0.2 $V_{DD}$	_	_	0.1 x V <sub>BB</sub>	V	
V <sub>OH(ISO)</sub>	Output High Voltage • $R_{ISO} = \infty \Omega$ , $T_X = 0.8 V_{DD}$	0.95 x V <sub>BB</sub>	_	_	V	

### 4.3 Dynamic electrical characteristics

#### Table 5. Dynamic electrical characteristics

Characteristics noted under conditions of 4.75 V  $\leq$  V<sub>DD</sub>  $\leq$  5.25 V, 8.0 V  $\leq$  V<sub>BB</sub>  $\leq$  18 V, -40 °C  $\leq$  T<sub>C</sub>  $\leq$  125 °C, unless otherwise noted.

Symbol	Characteristic	Min.	Тур.	Max.	Unit	Notes
t <sub>FALL(ISO)</sub>	Fall Time • R <sub>ISO</sub> = 510 Ω to V <sub>BB</sub> , C <sub>ISO</sub> = 10 nF to Ground	_	_	2.0	μs	(18)
t <sub>PD(ISO)</sub>	ISO Propagation Delay • High to Low: $R_{ISO}$ = 510 $\Omega$ , $C_{ISO}$ = 500 pF • Low to High: $R_{ISO}$ = 510 $\Omega$ , $C_{ISO}$ = 500 pF	- -	1 1	2.0 2.0	μs	(19) (20) (21)

#### Notes

- 18. Time required ISO voltage to transition from  $0.8 V_{BB}$  to  $0.2 V_{BB}$ .
- 19. Changes in the value of C<sub>ISO</sub> affect the rise and fall time but have minimal effect on Propagation Delay.
- 20. Step  $T_X$  voltage from 0.8  $V_{DD}$  to 0.2  $V_{DD}$ . Time measured from  $V_{IH(Tx)}$  until  $V_{ISO}$  reaches 0.3  $V_{BB}$ .
- Step T<sub>X</sub> voltage from 0.2 V<sub>DD</sub> to 0.8 V<sub>DD</sub>. Time measured from V<sub>IL(Tx)</sub> until V<sub>ISO</sub> reaches 0.7 V<sub>BB</sub>.

## 4.4 Electrical performance curves

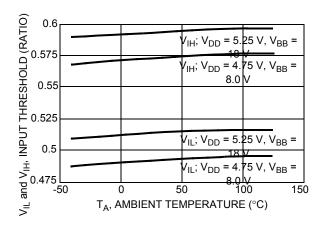


Figure 4. ISO input threshold/ $V_{BB}$  vs. temperature

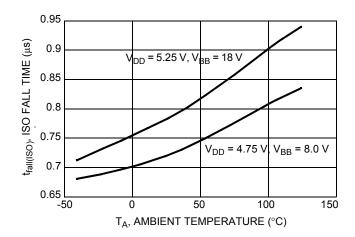


Figure 5. ISO output/ $V_{\rm BB}$  vs. temperature

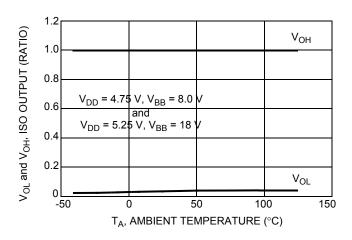


Figure 6. ISO fall time vs. temperature

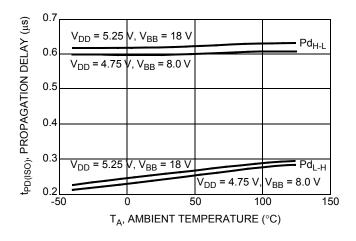


Figure 7. ISO propagation delay vs. temperature

# 5 Typical applications

#### 5.1 Introduction

The 33660 is a serial link bus interface device conforming to the ISO 9141 physical bus specification. The device is designed for automotive environment usage, compliant with On-board Diagnostics (OBD) requirements set forth by the California Air Resources Board (CARB) using the ISO K line. The device does not incorporate an ISO L line. It provides bi-directional half-duplex communications interfacing from a microcontroller to the communication bus. The 33660 incorporates circuitry to interface the digital translations from 5.0 V microcontroller logic levels to battery level logic, and from battery level logic to 5.0 V logic levels. The 33660 is built using Freescale Semiconductor's SMARTMOS process and is packaged in an 8-pin plastic SOIC.

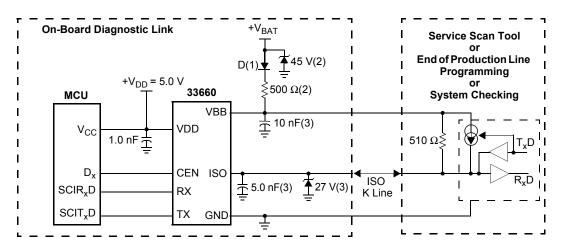
### 5.2 Functional description

The 33660 transforms 5.0 V microcontroller logic signals to battery level logic signals and vice versa. The maximum data rate is set by the rise and fall time. The fall time is set by the output driver. The rise time is set by the bus capacitance and the pull-up resistors on the bus. The fall time of the 33660 allows data rates up to 150 kbps using a 30 percent maximum bit time transition value. The serial link interface remains fully functional over a battery voltage range of 6.0 V to 18 V. The device is parametrically specified over a dynamic  $V_{BB}$  voltage range of 8.0 V to 18 V.

Required input levels from the microcontroller are ratio-metric with the  $V_{DD}$  voltage normally used to power the microcontroller. This enhances the 33660's ability to remain in harmony with the  $R_X$  and  $T_X$  control input signals of the microcontroller. The  $R_X$  and  $T_X$  control inputs are compatible with standard 5.0 V CMOS circuitry. For fault tolerant purposes the  $T_X$  input from the microcontroller has an internal passive pull-up to  $V_{DD}$ , while the CEN input has an internal passive pull-down to ground.

A pull-up to battery is internally provided as well as an active data pull-down. The internal active pull-down is current-limit protected against shorts to battery, and further protected by thermal shutdown. Typical applications have reverse battery protection by the incorporation of an external 510  $\Omega$  pull-up resistor and a diode to battery.

Reverse battery protection of the device is provided by the use of a reverse battery blocking diode (See "D" in the Typical application diagram on page 9). Battery line transient protection of the device is provided for by using a 45 V zener and a 500  $\Omega$  resistor connected to the V<sub>BB</sub> source, as shown in the same diagram. Device ESD protection from the communication lines exiting the module is through the use of the capacitor connected to the V<sub>BB</sub> device pin, and the capacitor used in conjunction with the 27 V zener connected to the ISO pin.



Components necessary for Reverse Battery (1), Overvoltage Transient (2), and 8.0 kV ESD Protection (3) in a metal module case.

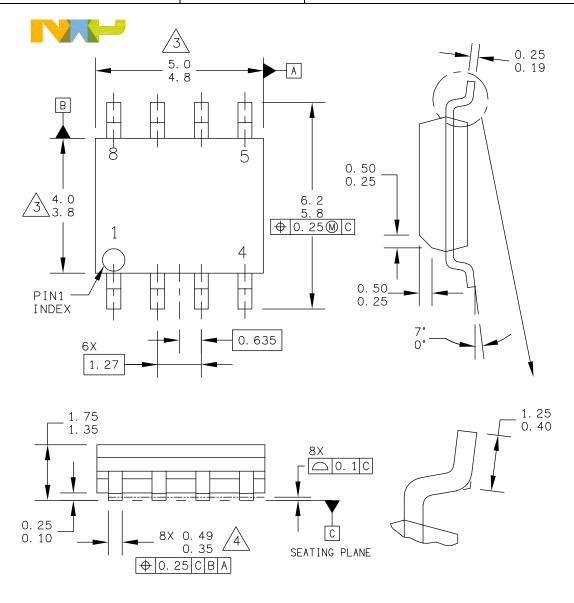
Figure 8. Typical application diagram

# 6 Packaging

## 6.1 Package mechanical dimensions

Package dimensions are provided in package drawings. To find the most current package outline drawing, go to www.NXP.com and perform a keyword search for the drawing's document number.

Package	Suffix	Package outline drawing number
8-Pin SOICN	EF	98ASB42564B

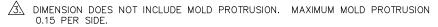


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#### NOTES:

- 1. DIMENSIONS ARE IN MILLIMETERS.
- 2. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.



DIMENSION DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 TOTAL IN EXCESS OF THE DIMENSION AT MAXIMUM MATERIAL CONDITION.

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33660

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# 7 Revision history

Revision	Date	Description of changes
1.0	1/2011	Initial release
2.0	9/2011	Adjusted format to meet current compliance standards. No data was altered.
3.0	10/2011	Updated the PC part number to MC.
4.0	2/2013	Added PC33660BEF to the ordering information Redefined VBB Load Dump Peak Voltage (in accordance with ISO 7637-2 & ISO 7637-3) for the 33660B Added Module Level ESD (Air Discharge, Powered) for the 33660B Added note (7) Increased ESD structure voltage for 33660B, and added bleed-off circuit on VBB pin in Figure 2
5.0	10/2013	Clarified machine model limits for MC33660 and MC33660B, page 5
6.0	1/2016	Changed document classification to Technical Data     Updated format and style
	7/2016	Updated to NXP document form and style

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Document Number: MC33660

Rev 6.0 7/2016

